

IGBT Module

SK10GD126ET

Preliminary Data

Features

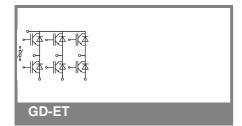
- Compact design
- · One screw mounting
- Heat transfer and isolation through direct copper bonded aluminium oxide ceramic (DCB)
- Ultrafast NPT technology IGBT
- CAL technology FWD
- Integrated NTC temperature sensor

Typical Applications*

Inverter

Absolute Maximum Ratings $T_s = 25 ^{\circ}\text{C}$, unless otherwise specified						
Symbol	Conditions			Values	Units	
IGBT					•	
V_{CES}	T _j = 25 °C			1200	V	
I _C	T _j = 150 °C	T _s = 25 °C		15	Α	
		T_s = 80 °C		11	Α	
I _{CRM}	I _{CRM} = 2 x I _{Cnom}			16	Α	
V_{GES}				± 20	V	
t _{psc}	V_{CC} = 600 V; $V_{GE} \le 20$ V; $V_{CES} < 1200$ V	T _j = 125 °C		10	μs	
Inverse D	Diode				•	
I _F	T _j = 150 °C	$T_s = 25 ^{\circ}C$		25	Α	
		$T_s = 80 ^{\circ}C$		17	Α	
I _{FRM}	I _{FRM} = 2 x I _{Fnom}			30	Α	
Module						
$I_{t(RMS)}$					Α	
T_{vj}				-40 + 150	°C	
T _{stg}				-40 + 125	°C	
V _{isol}	AC, 1 min.			2500	V	

Characteristics T _s = 25 °C, unless otherwise speci					ecified	
Symbol	Conditions		min.	typ.	max.	Units
IGBT						
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 0.3 \text{ mA}$		5	5,8	6,5	V
I _{CES}	$V_{GE} = 0 V, V_{CE} = V_{CES}$	T _j = 25 °C			0,05	mA
		T _j = 125 °C				mA
I _{GES}	V _{CE} = 0 V, V _{GE} = 20 V	T _j = 25 °C			120	nA
		T _j = 125 °C				nA
V_{CE0}		T _i = 25 °C		1	1,2	V
		T _j = 125 °C		0,9		V
r _{CE}	V _{GE} = 15 V	T _j = 25°C		87	113	mΩ
		T _j = 125°C		138		mΩ
V _{CE(sat)}	I _{Cnom} = 8 A, V _{GE} = 15 V	T _j = 25°C _{chiplev.}		1,7	2,1	V
		$T_j = 125^{\circ}C_{chiplev.}$		2,2		V
C _{ies}				0,6		nF
C _{oes}	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		0,037		nF
C _{res}				0,029		nF
t _{d(on)}				85		ns
t _r	$R_{Gon} = 75 \Omega$	V _{CC} = 600V		30		ns
E _{on}		I _C = 8A		1		mJ
t _{d(off)}	$R_{Goff} = 75 \Omega$	T _j = 125 °C		430		ns
t _f		V _{GE} =±15V		90		ns
E _{off}				1		mJ
$R_{th(j-s)}$	per IGBT				2	K/W





SEMITOP® 3

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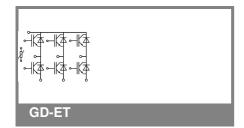
Typical Applications*

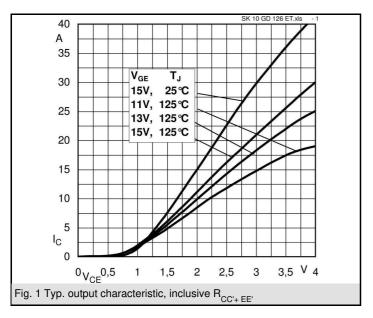
Inverter

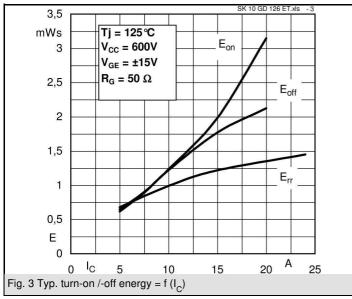
Characteristics							
Symbol	Conditions		min.	typ.	max.	Units	
Inverse D							
$V_F = V_{EC}$	I_{Fnom} = 8 A; V_{GE} = 0 V	$T_j = 25 ^{\circ}C_{\text{chiplev.}}$		1,9	2,2	V	
		$T_j = 125 ^{\circ}C_{\text{chiplev.}}$		2		V	
V _{F0}		T _j = 25 °C		1	1,1	V	
		T _j = 125 °C		0,8	0,9	V	
r _F		T _j = 25 °C		40	47	mΩ	
		T _j = 125 °C		53		$m\Omega$	
I _{RRM}	I _F = 15 A	T _j = 125 °C		21		Α	
Q_{rr}	di/dt = -300 A/µs			3,5		μC	
E _{rr}	V _{CC} = 600V			1,4		mJ	
$R_{th(j-s)D}$	per diode				2,1	K/W	
M _s	to heat sink		2,25		2,5	Nm	
w				30		g	
Temperature sensor							
R ₁₀₀	$T_s = 100$ °C ($R_{25} = 5$ kΩ)			493±5%		Ω	

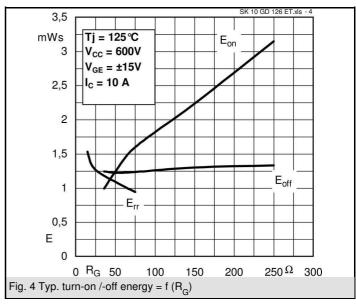
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

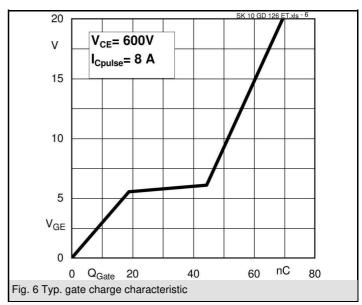
* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our personal.

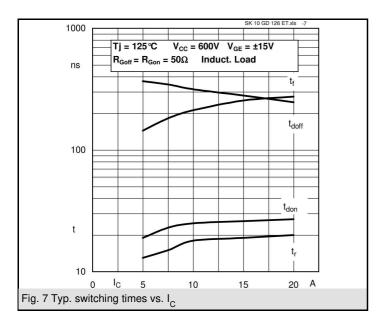


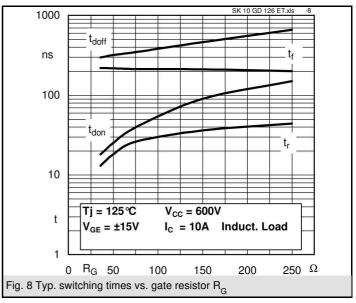


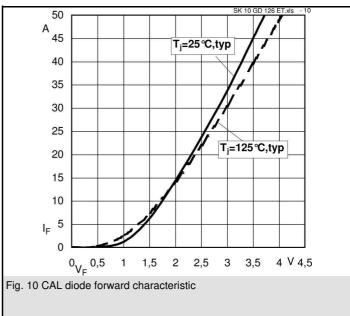




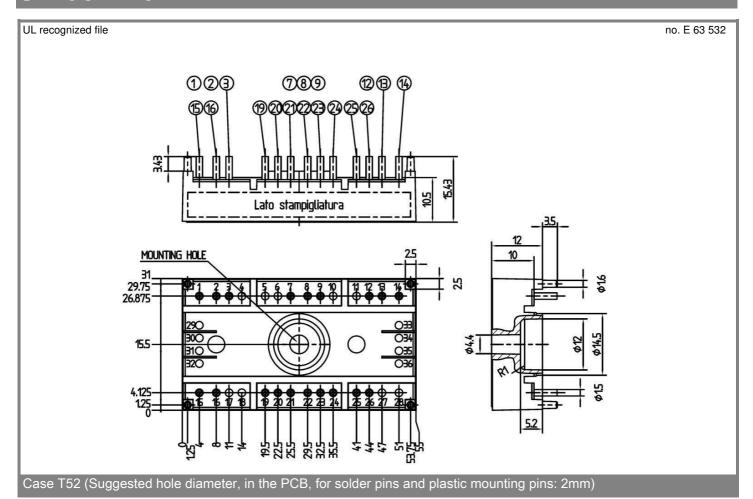


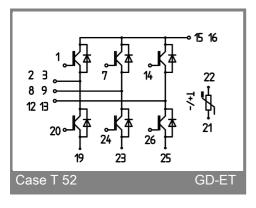






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